

# IGBT - Field Stop, Trench

1200 V, 25 A

## FGH25T120SMD

### Description

Using innovative field stop trench IGBT technology, ON Semiconductor's new series of field stop trench IGBTs offer the optimum performance for hard switching application such as solar inverter, UPS, welder and PFC applications.

### Features

- FS Trench Technology, Positive Temperature Coefficient
- High Speed Switching
- Low Saturation Voltage:  $V_{CE(sat)} = 1.8 \text{ V @ } I_C = 25 \text{ A}$
- 100% of the Parts Tested for  $I_{LM}$  (Note 1)
- High Input Impedance
- This Device is Pb-Free and is RoHS Compliant

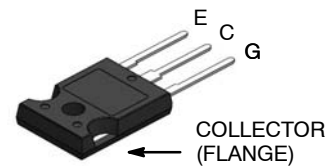
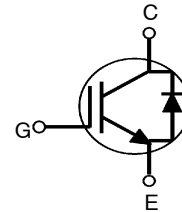
### Applications

- Solar Inverter, Welder, UPS & PFC Applications



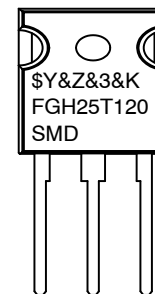
**ON Semiconductor®**

[www.onsemi.com](http://www.onsemi.com)



TO-247-3LD  
CASE 340CH

### MARKING DIAGRAMS



\$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Numeric Date Code
&K	= Lot Code
FGH25T120SMD	= Specific Device Code

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

# FGH25T120SMD

## ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, unless otherwise specified)

Parameter		Symbol	Ratings	Unit
Collector to Emitter Voltage		V <sub>CES</sub>	1200	V
Gate to Emitter Voltage		V <sub>GES</sub>	±25	V
Transient Gate to Emitter Voltage			±30	V
Collector Current	T <sub>C</sub> = 25°C	I <sub>C</sub>	50	A
Collector Current	T <sub>C</sub> = 100°C		25	A
Clamped Inductive Load Current (Note 1)		I <sub>LM</sub>	100	A
Pulsed Collector Current (Note 2)		I <sub>CM</sub>	100	A
Diode Continuous Forward Current	T <sub>C</sub> = 25°C	I <sub>F</sub>	50	A
Diode Continuous Forward Current	T <sub>C</sub> = 100°C		25	A
Diode Maximum Forward Current		I <sub>FM</sub>	200	A
Maximum Power Dissipation	T <sub>C</sub> = 25°C	P <sub>D</sub>	428	W
Maximum Power Dissipation	T <sub>C</sub> = 100°C		214	W
Operating Junction Temperature		T <sub>J</sub>	-55 to +175	°C
Storage Temperature Range		T <sub>stg</sub>	-55 to +175	°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		T <sub>L</sub>	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- V<sub>CC</sub> = 600 V, V<sub>GE</sub> = 15 V, I<sub>C</sub> = 100 A, R<sub>G</sub> = 23 Ω, Inductive Load
- Limited by T<sub>jmax</sub>

## THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case, Max. (IGBT)	R <sub>θJC</sub>	0.35	°C/W
Thermal Resistance, Junction to Case, Max. (Diode)	R <sub>θJC</sub>	1.4	°C/W
Thermal Resistance, Junction to Ambient, Max.	R <sub>θJA</sub>	40	°C/W

## PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FGH25T120SMD	FGH25T120SMD-F155	TO-247-3LD	-	-	30

## ELECTRICAL CHARACTERISTICS OF THE IGBT (T<sub>C</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

Collector to Emitter Breakdown Voltage	BV <sub>CES</sub>	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 250 μA	1200	-	-	V
Collector Cut-Off Current	I <sub>CES</sub>	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0 V	-	-	250	μA
G-E Leakage Current	I <sub>GES</sub>	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0 V	-	-	±400	nA

### ON CHARACTERISTICS

G-E Threshold Voltage	V <sub>GE(th)</sub>	I <sub>C</sub> = 25 mA, V <sub>CE</sub> = V <sub>GE</sub>	4.9	6.2	7.5	V
Collector to Emitter Saturation Voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> = 25 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 25°C	-	1.8	2.4	V
		I <sub>C</sub> = 25 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 175°C	-	1.9	-	V

## FGH25T120SMD

### ELECTRICAL CHARACTERISTICS OF THE IGBT ( $T_C = 25^\circ\text{C}$ unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>DYNAMIC CHARACTERISTICS</b>						
Input Capacitance	$C_{ies}$	$V_{CE} = 30\text{ V}, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$	–	2800	–	pF
Output Capacitance	$C_{oes}$		–	105	–	pF
Reverse Transfer Capacitance	$C_{res}$		–	60	–	pF
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	$t_{d(on)}$	$V_{CC} = 600\text{ V}, I_C = 25\text{ A},$ $R_G = 23\ \Omega, V_{GE} = 15\text{ V},$ Inductive Load, $T_C = 25^\circ\text{C}$	–	40	–	ns
Rise Time	$t_r$		–	45	–	ns
Turn-Off Delay Time	$t_{d(off)}$		–	490	–	ns
Fall Time	$t_f$		–	12	–	ns
Turn-On Switching Loss	$E_{on}$		–	1.74	–	mJ
Turn-Off Switching Loss	$E_{off}$		–	0.56	–	mJ
Total Switching Loss	$E_{ts}$		–	2.30	–	mJ
Turn-On Delay Time	$t_{d(on)}$	$V_{CC} = 600\text{ V}, I_C = 25\text{ A},$ $R_G = 23\ \Omega, V_{GE} = 15\text{ V},$ Inductive Load, $T_C = 175^\circ\text{C}$	–	40	–	ns
Rise Time	$t_r$		–	48	–	ns
Turn-Off Delay Time	$t_{d(off)}$		–	520	–	ns
Fall Time	$t_f$		–	64	–	ns
Turn-On Switching Loss	$E_{on}$		–	2.94	–	mJ
Turn-Off Switching Loss	$E_{off}$		–	1.09	–	mJ
Total Switching Loss	$E_{ts}$		–	4.03	–	mJ
Total Gate Charge	$Q_g$	$V_{CE} = 600\text{ V}, I_C = 25\text{ A}, V_{GE} = 15\text{ V}$	–	225	–	nC
Gate to Emitter Charge	$Q_{ge}$		–	20	–	nC
Gate to Collector Charge	$Q_{gc}$		–	128	–	nC

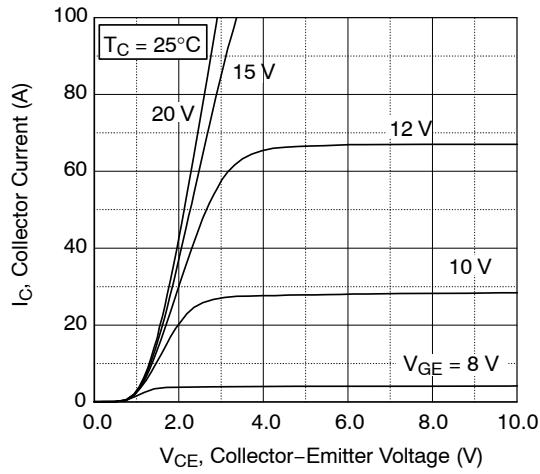
### ELECTRICAL CHARACTERISTICS OF THE DIODE ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Diode Forward Voltage	$V_{FM}$	$I_F = 25\text{ A}, T_C = 25^\circ\text{C}$	–	2.8	3.7	V
		$I_F = 25\text{ A}, T_C = 175^\circ\text{C}$	–	2.1	–	V
Diode Reverse Recovery Time	$t_{rr}$	$V_R = 600\text{ V}, I_F = 25\text{ A},$ $di_F/dt = 200\text{ A}/\mu\text{s}, T_C = 25^\circ\text{C}$	–	60	–	ns
Diode Peak Reverse Recovery Current	$I_{rr}$		–	6.6	–	A
Diode Reverse Recovery Charge	$Q_{rr}$		–	197	–	nC
Reverse Recovery Energy	$E_{rec}$	$V_R = 600\text{ V}, I_F = 25\text{ A},$ $di_F/dt = 200\text{ A}/\mu\text{s}, T_C = 175^\circ\text{C}$	–	330	–	$\mu\text{J}$
Diode Reverse Recovery Time	$t_{rr}$		–	325	–	ns
Diode Peak Reverse Recovery Current	$I_{rr}$		–	13	–	A
Diode Reverse Recovery Charge	$Q_{rr}$		–	2113	–	nC

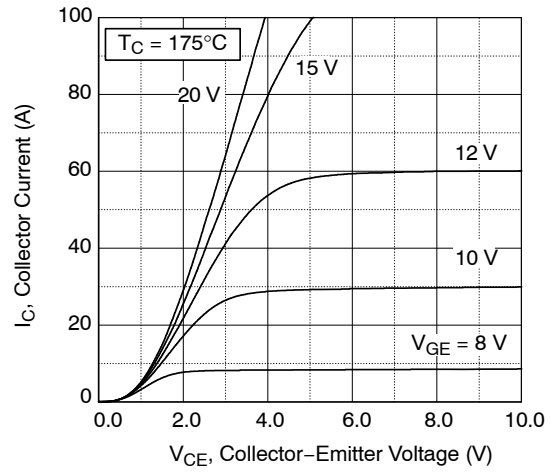
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# FGH25T120SMD

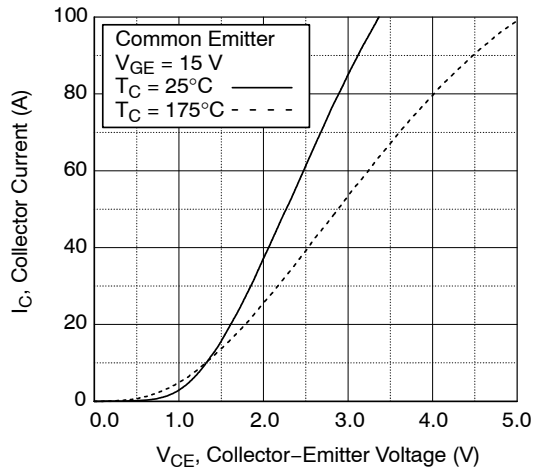
## TYPICAL PERFORMANCE CHARACTERISTICS



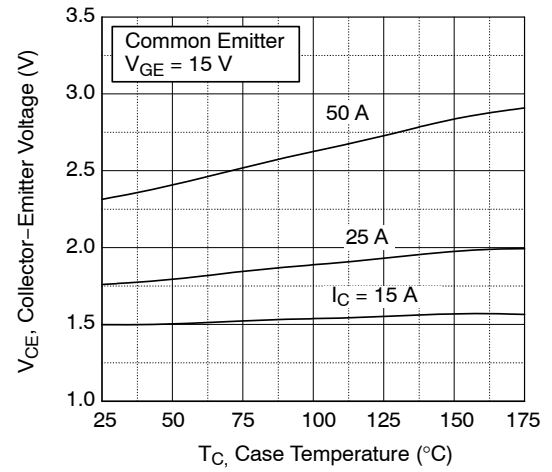
**Figure 1. Typical Output Characteristics**



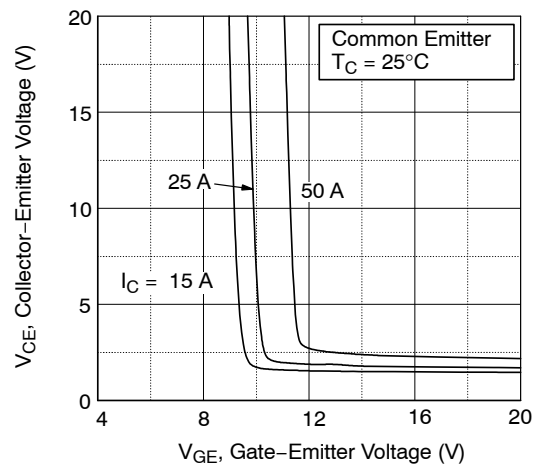
**Figure 2. Typical Output Characteristics**



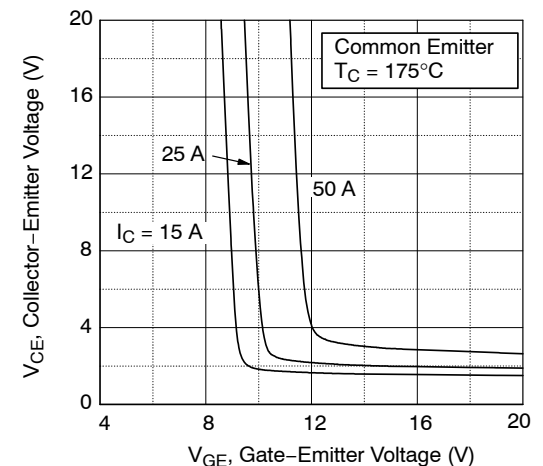
**Figure 3. Typical Saturation Voltage Characteristics**



**Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level**



**Figure 5. Saturation Voltage vs.  $V_{GE}$**



**Figure 6. Saturation Voltage vs  $V_{GE}$**

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

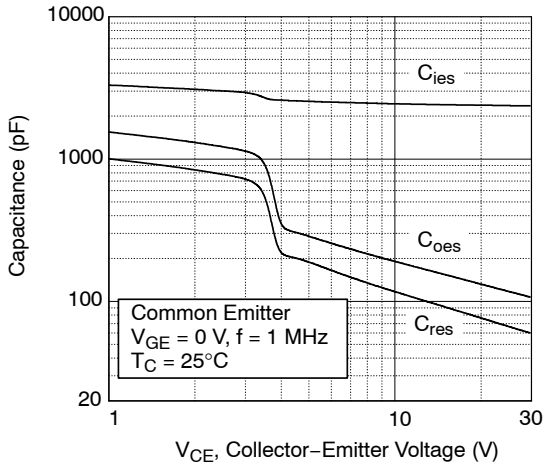


Figure 7. Capacitance Characteristics

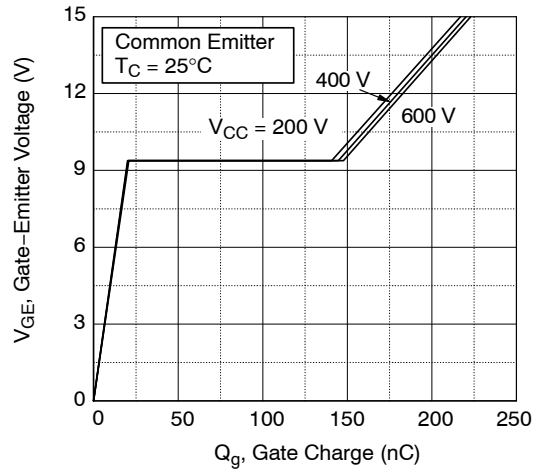


Figure 8. Gate Charge Characteristics

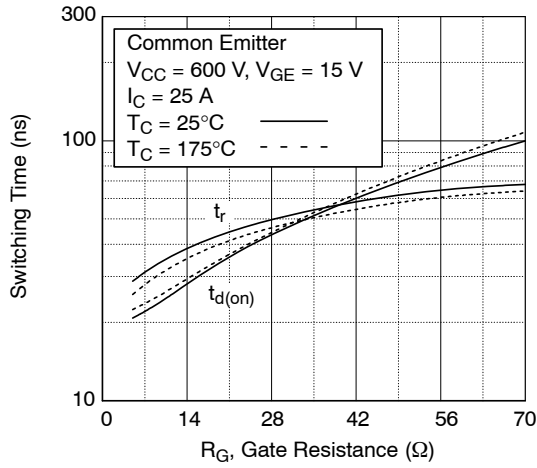


Figure 9. Turn-On Characteristics vs. Gate Resistance

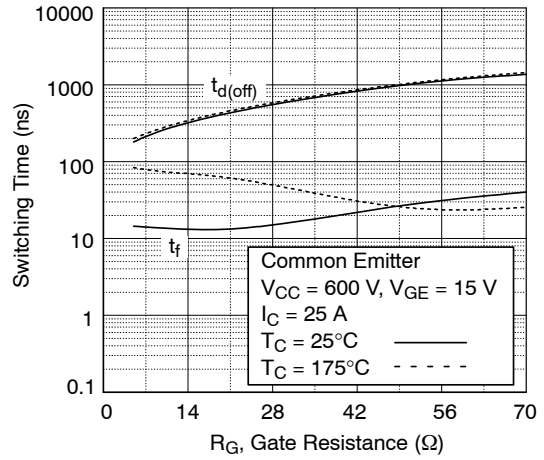


Figure 10. Turn-Off Characteristics vs. Gate Resistance

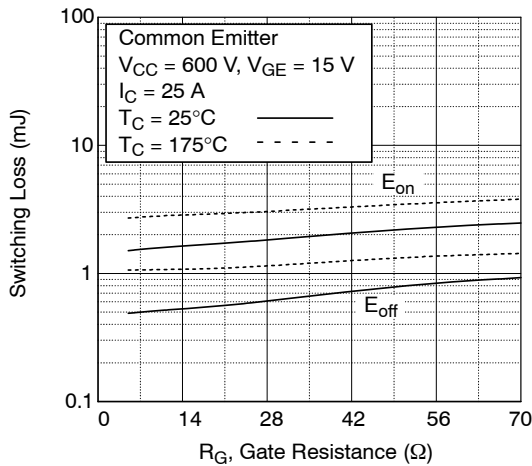


Figure 11. Switching Loss vs. Gate Resistance

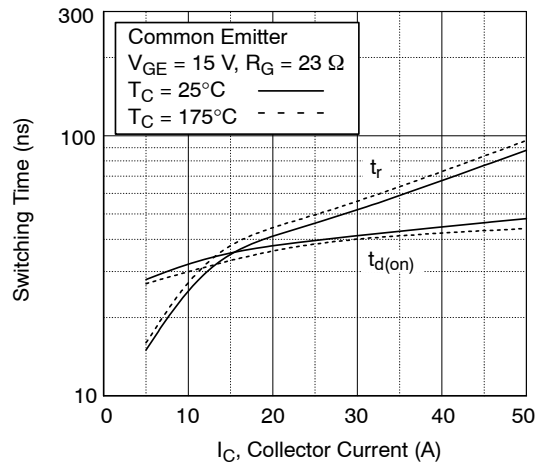
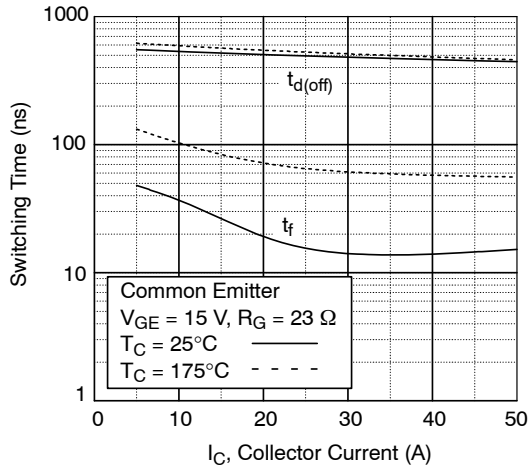


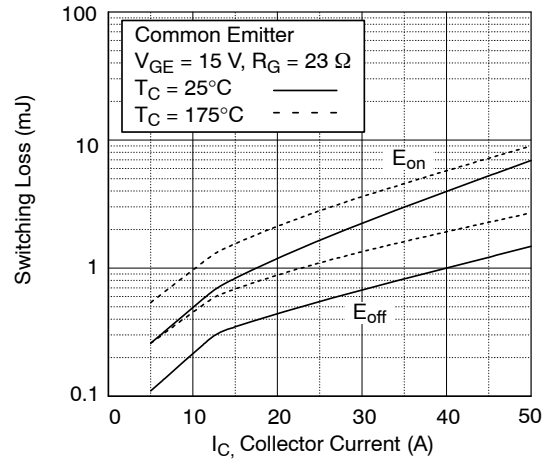
Figure 12. Turn-On Characteristics vs. Collector Current

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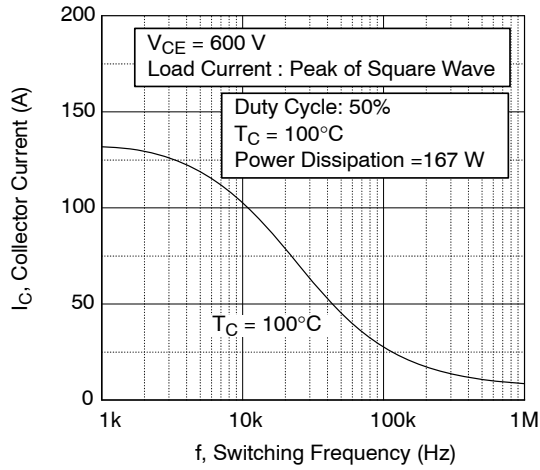
## TYPICAL PERFORMANCE CHARACTERISTICS (continued)



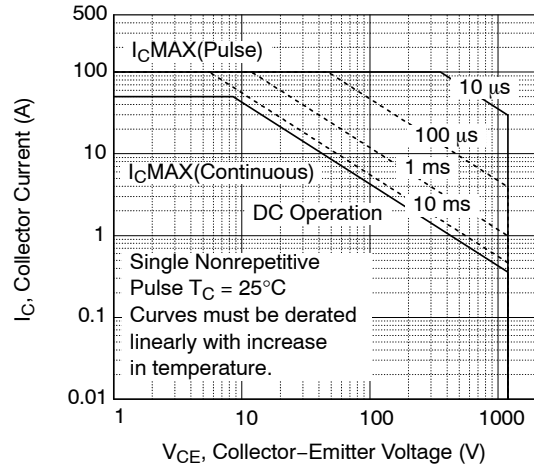
**Figure 13. Turn-Off Characteristics vs. Collector Current**



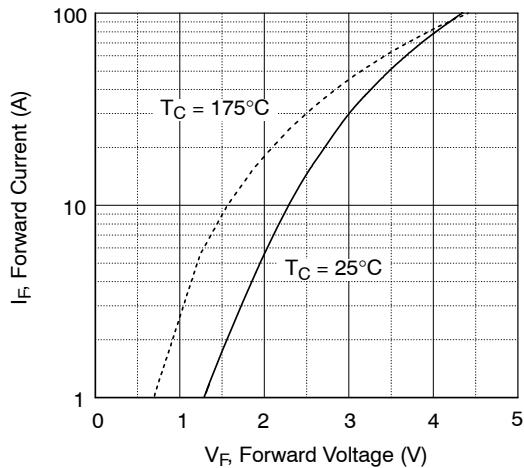
**Figure 14. Switching Loss vs. Collector Current**



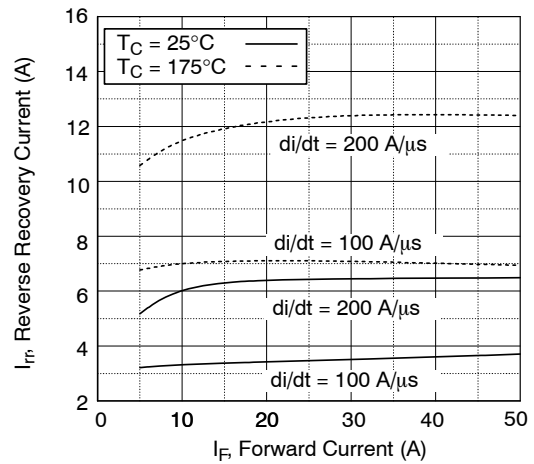
**Figure 15. Load Current vs. Frequency**



**Figure 16. SOA Characteristics**



**Figure 17. Forward Characteristics**



**Figure 18. Reverse Recovery Current**

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## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

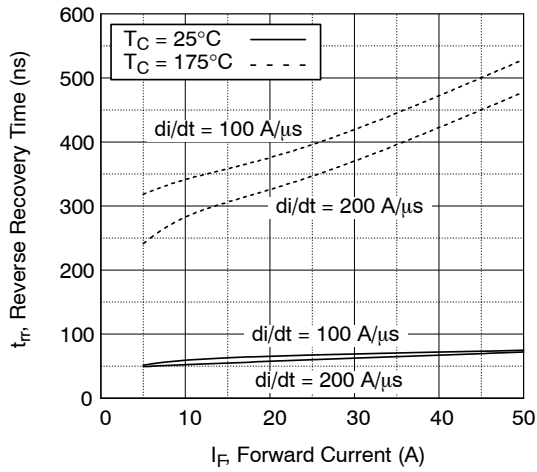


Figure 19. Reverse Recovery Time

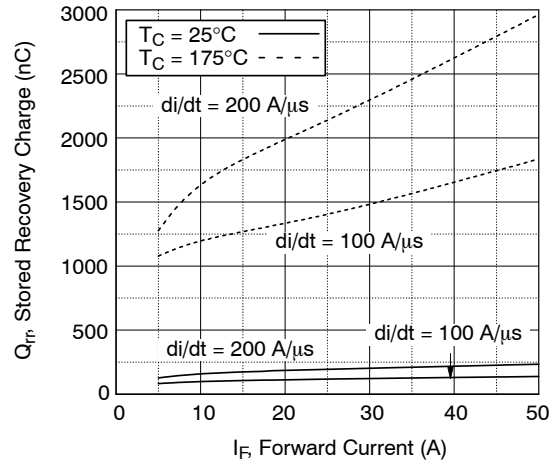


Figure 20. Stored Charge

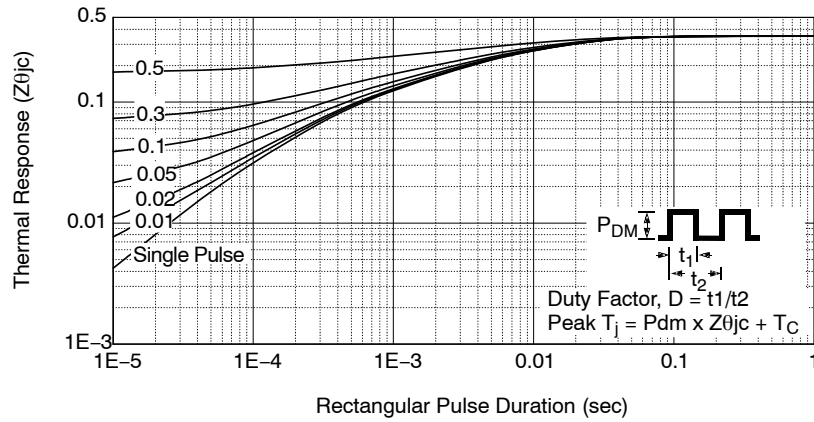


Figure 21. Transient Thermal Impedance of IGBT

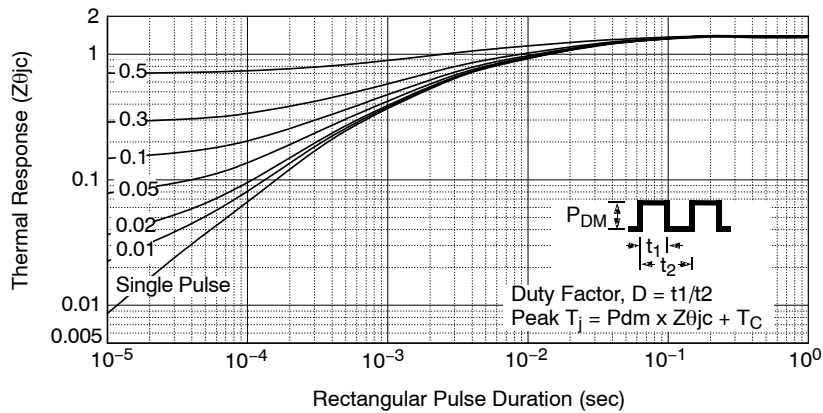


Figure 22. Transient Thermal Impedance of Diode

# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS

ON Semiconductor®



TO-247-3LD  
CASE 340CH  
ISSUE A

DATE 09 OCT 2019



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 - 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

### GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code  
A = Assembly Location  
Y = Year  
WW = Work Week  
G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.58	4.70	4.82
A1	2.29	2.475	2.66
A2	1.40	1.50	1.60
D	20.32	20.57	20.82
E	15.37	15.62	15.87
E2	4.96	5.08	5.20
e	~	5.56	~
L	19.75	20.00	20.25
L1	3.69	3.81	3.93
∅P	3.51	3.58	3.65
Q	5.34	5.46	5.58
S	5.34	5.46	5.58
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
c	0.51	0.61	0.71
D1	13.08	~	~
D2	0.51	0.93	1.35
E1	12.81	~	~
∅P1	6.61	6.73	6.85

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<b>DESCRIPTION:</b>	<b>TO-247-3LD</b>	<b>PAGE 1 OF 1</b>

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